Appl. No. :

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LISTING OF CLAIMS

1. (Previously presented) A method of electrochemically filling cavities on a wafer surface to form a substantially planar conductive layer, comprising the steps of:

applying a first cathodic current to form a first conductive layer on the wafer surface, the wafer having a first cavity and a second cavity, wherein the first cavity has the smallest width and the second cavity has a larger width than the first cavity, and wherein the first and the second cavities are less than 10 micrometers in width;

treating a surface of the first conductive layer by applying a first anodic current waveform;

applying a second cathodic current to form a second conductive layer on the first conductive layer; and

treating a surface of the second conductive layer by applying a second anodic current waveform,

wherein the second anodic current waveform has a longer duration than the first anodic current waveform.

- 2. (Canceled)
- 3. (Canceled)
- 4. (Previously presented) The method of claim 1, wherein the step of treating the surface of the first conductive layer prevents bump formation on the surface of the first conductive layer.
- 5. (Original) The method of claim 1, wherein the steps of applying first and second cathodic currents comprise applying DC voltage.
- 6. (Original) The method of claim 1, wherein the steps of applying first and second cathodic currents comprise applying AC voltage.
- 7. (Previously presented) The method of claim 1, further comprising repeating the steps of treating and applying until all the cavities on the wafer surface are filled.
 - 8. (Canceled)
- 9. (Previously presented) A method to electrochemically fill a plurality of cavities on a wafer surface comprising:

applying a first cathodic current to fill a first cavity and partially fill a second cavity with a first conductive layer on the wafer surface, the first cavity having a smaller

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width than the second cavity wherein the first cavity and the second cavity each include a width less than 10 micrometers;

applying a first anodic current waveform to treat the first conductive layer, the first anodic current waveform comprising at least one anodic current pulse;

applying a second cathodic current to fill the second cavity with a second conductive layer to form a substantially planar conductive layer over the first cavity and the second cavity; and

applying a second anodic current waveform to treat the second conductive layer, the second anodic current waveform comprising at least one anodic current pulse,

wherein the second anodic current waveform has a longer duration than the first anodic current waveform.

- 10. (Previously presented) The method of claim 9, wherein applying the first cathodic current includes applying a cathodic DC waveform.
- 11. (Previously presented) The method of claim 9, wherein applying the first cathodic current includes applying a cathodic AC waveform.
- 12. (Previously presented) The method of claim 9, wherein the first anodic current waveform includes a plurality of anodic current pulses.
- 13. (Previously presented) The method of claim 12, wherein the anodic current pulses are each approximately 1 second in duration.
 - 14. (Canceled)
- 15. (Previously presented) A method of electrochemically filling cavities on a wafer surface to form a planar conductive layer, comprising:

providing a first cavity with a smallest width and a second cavity having a larger width than the first cavity, wherein the first and second cavities are less than 10 micrometers in width;

applying a first cathodic current waveform to form a first conductive layer on the wafer surface;

treating the first conductive layer by applying a first anodic current waveform;

applying a second cathodic current waveform to form a second conductive layer on the first conductive layer, the second conductive layer having a planar portion over the first cavity; and Appl. No. : 10/769,605

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treating the second conductive layer by applying a second anodic current waveform,

wherein the second cathodic current waveform has a longer duration than the first cathodic current waveform and the second anodic current waveform has a longer duration than the first anodic current waveform.

- 16. (Previously presented) The method of claim 15, wherein applying the first cathodic current includes applying a cathodic rectangular waveform.
 - 17. (Canceled)
 - 18. (Canceled)
 - 19. (Canceled)
 - 20. (Original) The method of claim 15, wherein the planar conductive layer is copper.
- 21. (Previously presented) The method of claim 1, wherein the step of applying the first cathodic current comprises forming the first conductive layer including a planar portion over the first cavity and a non-planar portion over the second cavity.
- 22. (Previously presented) The method of claim 1, wherein the step of applying the second cathodic current comprises forming the second conductive layer including a planar portion over both the first and second cavities.
- 23. (Previously presented) The method of claim 1, wherein the step of treating the surface of the second conductive layer prevents bump formation on the surface of the second conductive layer.
- 24. (Previously presented) The method of claim 1, wherein the second anodic current waveform includes a greater number of anodic current pulses than the first anodic current waveform.
- 25. (Previously presented) The method of claim 1, wherein the second cathodic current is applied for a longer time than the first cathodic current.
- 26. (Previously presented) The method of claim 9, wherein applying the second cathodic current includes applying a cathodic DC waveform.
- 27. (Previously presented) The method of claim 9, wherein applying the second cathodic current includes applying a cathodic AC waveform.

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28. (Previously presented) The method of claim 9, wherein the second anodic current waveform includes a greater number of anodic current pulses than the first anodic current waveform.

- 29. (Previously presented) The method of claim 9, wherein the second cathodic current is applied for a longer time than the first cathodic current.
- 30. (Previously presented) The method of claim 9, wherein the second anodic current waveform includes a plurality of anodic current pulses.
- 31. (Previously presented) The method of claim 30, wherein the anodic current pulses are each approximately 1 second in duration.
- 32. (Previously presented) The method of claim 15, wherein the second cathodic current waveform is a cathodic rectangular waveform.
- 33. (Previously presented) The method of claim 15, wherein the first anodic current waveform includes a plurality of anodic current pulses of approximately 1 second in duration.
- 34. (Previously presented) The method of claim 15, wherein the second anodic current waveform includes a plurality of anodic current pulses of approximately 1 second in duration.
- 35. (Previously presented) The method of claim 15, wherein the second anodic current waveform includes a greater number of anodic current pulses than the first anodic current waveform.
- 36. (Previously presented) The method of claim 15, wherein applying the first cathodic current waveform comprises forming the first conductive layer including a planar portion over the first cavity and a non-planar portion over the second cavity.
- 37. (Previously presented) The method of claim 36, wherein the first cavity is filled and the second cavity is unfilled.